

**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

(Use as many sheets as necessary)

Sheet	1	of	1	Attorney Docket Number	09947.0002
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Complete if Known

Application Number	10/550,302
Filing Date	September 22, 2005
First Named Inventor	Michihiro Ohnishi
Art Unit	1634
Examiner Name	Forman, Betty J.

U.S. PATENTS AND PUBLISHED U.S. PATENT APPLICATIONS

Examiner Initials	Cite No. ¹	Document Number	Issue or Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			

Note: Copies of the U.S. Patent Documents are not Required in IDS filed after October 21, 2004

FOREIGN PATENT DOCUMENTS

Examiner Initials	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	Translation ⁶
		Country Code ³ Number ⁴ Kind Code ⁵ (if known)				
		WO 96/14934 A1	05-23-1996	Trustees of the University of Pennsylvania		

NON PATENT LITERATURE DOCUMENTS

Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	Translation ⁶
		Darwin R. Reyes et al., "Micro total analysis systems. 1. Introduction, theory, and technology," Anal. Chem., vol. 74, no. 12 (2002) pp. 2623-2636.	
		English translation of the first Office Action issued from the State Intellectual Property Office of the People's Republic of China on May 9, 2008 in related Chinese Patent Application No. 200480008284.3.	

Examiner Signature	Date Considered
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